Ò|^&c¦ [|•cæcã&Áåã•&@æ¦*^ÁÚ¦[c^&cã[}ÁÖ^çã&^•ÇÒÙÖDÁ

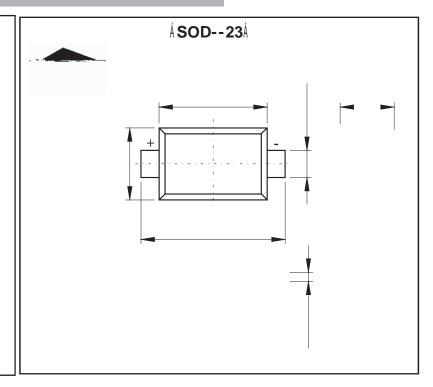
:95HIF9G"

- ●ÁÜ^ç^¦•^Á¸[¦\ã}*ÇÙœ}åĒ[~DÁç[|œ*^•KÍ X
- ●ÁŠ[¸Á|^æ\æ*^ÈÁ
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5DD@=75H=CBG

 $\ddot{O} \wedge \bullet \ddot{a}^* \wedge \mathring{a} \wedge [\mathring{A}]^! [c \wedge \& c \mathring{A}_{c} [c \varpi^* \wedge \mathring{A}_{o}^*) \bullet \mathring{a} \mathring{a} \mathring{A} \wedge [\mathring{A}]^! [c \wedge \& c \mathring{A}_{c} [c \varpi^* \wedge \mathring{A}_{o}^*) \bullet \mathring{a} \mathring{A} \mathring{A} \wedge [\varpi]^* \mathring{A} \mathring{A} \mathring{A} \wedge [\varpi]^* \mathring{A} \mathring{A} \mathring{A} \wedge [\varpi]^* \mathring{A} \wedge [\varpi]^* \mathring{A} \mathring{A} \wedge [\varpi]^* \mathring{A} \mathring{A} \wedge [\varpi]^* \mathring{A} \mathring{A} \wedge [\varpi]^* \mathring{$

 $\hat{O} \hat{x} - \hat{A} \cdot \hat{c} - \hat{A} \cdot \hat{c} = \hat{A} \cdot \hat{d} = \hat{$

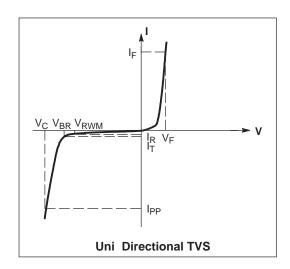


A5L=A1A'F5H=B; G'5B8'7<5F57H9F=GH=7G

O GͻԌ{ài^}c V^{]^!æc"!^ (;"}|^•• [c@^!;i•^}[c^åD

FUh]b[Gm a Vc`	JU`iY	l b]h

Symbol	Parameter			
I _{PP}	Maximum Reverse Peak Pulse Current			
V _C	Clamping Voltage @ I _{PP}			
V _{RWM}	Working Peak Reverse Voltage			
I _R	Maximum Reverse Leakage Current @ V _{RWM}			
V _{BR}	Breakdown Voltage @ I _T			
I _T	Test Current			
I _F	Forward Current			
V _F	Forward Voltage @ I _F			
P _{pk}	Peak Power Dissipation			
С	Capacitance @ V _R = 0 and f = 1.0 MHz			



		V _{RWM} (V)	Ι _R (μΑ) @ V _{RWM}	V _{BR} (V) @ I _T (Note 2)	I _T	C (pF)	V _C (V) @ I _{PP} = 1 A (Note 3)	Vc
Device	Device Marking	Max	Max	Min	mA			